

PRODUCT/PROCESS CHANGE NOTIFICATION

PCN MPA-PWR/06/1901 Notification Date 07/10/2006

SILICON LINE CHANGE FOR BV32 FAMILY PRODUCTS PWR - PWR BIP/ IGBT/ RF

Table 1. Change Identification

Product Identification (Product Family/Commercial Product)	POWER Bipolar Transistors line BV32			
Type of change	Waferfab process change			
Reason for change	Production optimization			
Description of the change	Silicon line change for bipolar transistor as per the enclosed table. Such sales types, presently produced with the BV32 Planar technology silicon line, will be produced with the BV77 line, same technology, same diffusion , assembly and testing locations. The BV77 line has been designed with the same active area and same process used for the BV32 and optimizing the edge structure.			
Product Line(s) and/or Part Number(s)	See attached			
Description of the Qualification Plan	See attached			
Change Product Identification	Letter "N" on additional info			
Manufacturing Location(s)				

Table 2. Change Implementation Schedule

Forecasted implementation date for change	01-Oct-2006
Forecasted availabillity date of samples for customer	06-Jul-2006
Forecasted date for STMicroelectronics change Qualification Plan results availability	06-Jul-2006
Estimated date of changed product first shipment	08-Oct-2006

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Table 3. Change Responsibility

	Name	Signature	Date
Division Product Manager	Claudio Porto		Jul.06 ,06
Division Q.A. Manager	Giuseppe Falcone		Jul.06 ,06
Division Marketing Manager	Alfio Lanzafame		Jul.06 ,06

Table 4. List of Attachments

Customer Part numbers list	
Qualification Plan results	

Customer Acknowledgement of Receipt	PCN MPA-PWR/06/1901
Please sign and return to STMicroelectronics	Sales Office Notification Date 07/10/2006
□ Qualification Plan Denied	Name:
□ Qualification Plan Approved	Title:
	Company:
□ Change Denied	Date:
□ Change Approved	Signature:
Remark	

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Reliability Evaluation Plan and results on ST13003

REL-073/06W April '06 Line...... BV77
Package..... SOT-32

Test	Conditions	S.S.	Requirement	Results
H.T.S	TA=150°C	77 x 1 Lot	Parameter deviation within spec. limits at 1000 hours.	No parameter deviation out of spec. limits at 1000 hours.
T.H.B.	TA=85°C - RH=85% Vbias = 100V	77 x 1 Lot	Parameter deviation within spec. limits at 1000 hours.	No parameter deviation out of spec. limits at 1000 hours.
H.T.R.B.	T.A.=150°C ; Vces=560 V	77 x 1 Lot	Parameter deviation within spec. limits at 1000 hours.	No parameter deviation out of spec. limits at 1000 hours.
PRESSURE POT	TA=121°C - PA=2Atm	77 x 1 Lot	Parameter deviation within spec. limits at 96 hours.	No parameter deviation out of spec. limits at 96 hours.
THERMAL CYCLES AIR TO AIR	TA=-65°C TO +150°C 1 HOUR / CYCLE	77 x 1 Lot	Parameter deviation within spec. limits at 500 cycles.	No parameter deviation out of spec. limits at 500 cycles.
THERMAL FATIGUE	ΔTC=105°C - Pd=3W	77 x 1 Lot	Parameter deviation within spec. limits at 10k cycles.	No parameter deviation out of spec. limits at 10 Kcycles.



Micro, Power, Analog - MPA Group Quality Assurance & Reliability

Reliability Evaluation Plan and results on STD13003

REL-071/06W April 2006 Line...... BV77 Package..... DPAK

Test	Conditions	S.S.	Requirement	Results
PRECONDITIONING OF SMD DEVICES BEFORE TC/THB/ENV. SEQ.	DRYNG 1H @ 125°C STORE 168H @ TA=85°C RH=85% Reflow @ 260°C 3 times	204 x 1 Lot	Parameter deviation within spec. limits at end of preconditioning.	No parameter deviation out of spec. limits at end of preconditioning.
H.T.S.	TA=150°C	77 x 1 Lot	Parameter deviation within spec. limits at 1000 hours.	No parameter deviation at 1000 hours.
т.н.в.	D.U.T. SMD PRECONDITIONED TA=85°C - RH=85% Vbias= 100V	77 x 1 Lot	Parameter deviation within spec. limits at 1000 hours.	No parameter deviation at 1000 hours
H.T.R.B.	T.A.= 150°C Vces = 560V	77 x 1 Lot	Parameter deviation within spec. limits at 1000 hours.	No parameter deviation at 1000 hours
PRESSURE POT	TA=121°C - PA=2Atm	77 x 1 Lot	Parameter deviation within spec. limits at 96 hours.	No parameter deviation at 96 hours
THERMAL CYCLES AIR TO AIR	D.U.T. SMD PRECONDITIONED TA=-65°C TO 150°C 1 HOUR / CYCLE	77 x 1 Lot	Parameter deviation within spec. limits at 500 cycles.	No parameter deviation at 500 cy
THERMAL FATIGUE	ΔTC=105°C - Pd=2W	77 x 1 Lot	Parameter deviation within spec. limits at 10k cycles.	No parameter deviation at 10Kcy.
ENVIRONMENTAL SEQUENCE	D.U.T. SMD PRECONDITIONED 100 THERMAL CYCLES + 168H PP	50 x 1 Lot	Parameter deviation within spec. limits at end of test.	No parameter deviation at end of test.



Reliability Evaluation Plan and results on STX13003

REL-072-06/W April 2006 Line...... BV77 Package..... TO92

Test	Conditions	S.S.	Requirement	Results
H.T.S.	TA=150°C	77 x 1 Lot	Parameter deviation within spec. limits at 1000 hours.	No parameter deviation out of spec. limits at 1000 hours.
T.H.B.	TA=85°C - RH=85% Vbias= 100V	77 x 1 Lot	Parameter deviation within spec. limits at 1000 hours.	No parameter deviation out of spec. limits at 1000 hours.
H.T.R.B.	T.A.= 150°C Vces = 560 V	77 x 1 Lot	Parameter deviation within spec. limits at 1000 hours.	No parameter deviation out of spec. limits at 1000 hours.
PRESSURE POT	TA=121°C - PA=2Atm	77 x 1 Lot	Parameter deviation within spec. limits at 96 hours.	No parameter deviation out of spec. limits at 96 hours.
THERMAL CYCLES AIR TO AIR	TA=-65°C TO 150°C 1 HOUR / CYCLE	77 x 1 Lot	Parameter deviation within spec. limits at 500 cycles.	No parameter deviation out of spec. limits at 1000 cy
ENVIRONMENTAL SEQUENCE	100 THERMAL CYCLES + 168H PP	50 x 1 Lot	Parameter deviation within spec. limits at end of test.	No parameter deviation at end of test.

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